

650V N-Channel Power MOSFET

Features

- High Voltage: $BV_{DSS}=650V(\text{Min.})$
- $I_D : 4A$
- Robust high voltage termination
- Avalanche energy specified
- Fast diode recovery time



1 2 3

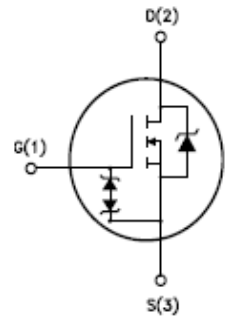
TO-252

Pin Definition

1. Gate
2. Drain
3. Source

Application

- Ballast Bridge
- Switch Mode Power Supplier
- Power Factor Correction
- Lighting



Ordering Information

Type NO	Marking	Package Code
WMD4N65S	4N65D	TO-252

Absolute maximum ratings ($T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Rating	Unit	
Drain-source voltage	V_{DSS}	650	V	
Gate-source voltage	V_{GSS}	± 30	V	
Drain current (DC) *	I_D	$T_C=25^\circ\text{C}$	4.0	A
		$T_C=100^\circ\text{C}$	2.53	A
Drain current (Pulsed) *	I_{DM}	16	A	
Single avalanche energy ②	E_{AS}	52	mJ	
Repetitive avalanche current ①	I_{AR}	2.5	A	
Repetitive avalanche energy ①	E_{AR}	3.2	mJ	
Power dissipation	P_D	50	W	
Junction temperature	T_J	150	$^\circ\text{C}$	
Storage temperature range	T_{stg}	-55~150	$^\circ\text{C}$	

* Limited by maximum junction temperature

Characteristic	Symbol	Typ.	Unit	
Thermal resistance	Junction-case	$R_{th(J-C)}$	4.16	$^\circ\text{C/W}$
	Junction-ambient	$R_{th(J-A)}$	62.5	

Electrical Characteristics (T_C=25°C unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	BV _{DSS}	I _D =250 μA, V _{GS} =0V	650	-	-	V
Gate threshold voltage	V _{GS(th)}	I _D =250 μA, V _{DS} =V _{GS}	2.0	-	4.0	V
Drain-source cut-off current	I _{DSS}	V _{DS} =650V, V _{GS} =0V, T _C =25°C	-	-	1	μA
		V _{DS} =520V, V _{GS} =0V, T _C =125°C	-	-	100	μA
Gate leakage current	I _{GSS}	V _{DS} =0V, V _{GS} =±20V	-	-	±10	μA
Drain-source on-resistance	R _{DS(on)}	V _{GS} =10V, I _D =2A	-	2.3	2.8	Ω
Forward transfer conductance ③	g _{fs}	V _{DS} =15V, I _D =2A	-	3.5	-	S
Input capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V f=1 MHz	-	560	-	pF
Output capacitance	C _{oss}		-	51	-	
Reverse transfer capacitance	C _{rss}		-	2.2	-	
Turn-on delay time ③④	t _{d(on)}	V _{DD} =325V, I _D =4A R _G =10Ω	-	15	-	ns
Rise time ③④	t _r		-	23	-	
Turn-off delay time ③④	t _{d(off)}		-	30	-	
Fall time ③④	t _f		-	16	-	
Total gate charge ③④	Q _g	V _{DD} =520V, V _{GS} =10V I _D =4A	-	14	-	nC
Gate-source charge ③④	Q _{gs}		-	3	-	
Gate-drain charge ③④	Q _{gd}		-	6	-	

Source-Drain Diode Ratings and Characteristics (T_C=25°C unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Source current (DC)	I _S	Integral reverse diode in the MOSFET	-	-	4.0	A
Source current (Pulsed)	I _{SM}		-	-	16.0	
Forward voltage	V _{SD}	V _{GS} =0V, I _{SD} =4A	-	-	1.5	V
Reverse recovery time ③④	t _{rr}	I _{SD} =4A, V _{GS} =0V dI _F /dt=100A/μs	-	315	-	ns
Reverse recovery charge ③④	Q _{rr}		-	1.2	-	μC

Note ;

1. Repetitive rating : Pulse width limited by safe operating area
2. L=10mH, I_{AS}=4A, V_{DD}=50V, R_G=25 Ω, Starting T_J=25°C
3. Pulse Test : Pulse width ≤ 300 μs, Duty cycle ≤ 2%
4. Essentially independent of operating temperature typical characteristics

Electrical Characteristic Curves

Fig. 1 Typical Output Characteristics

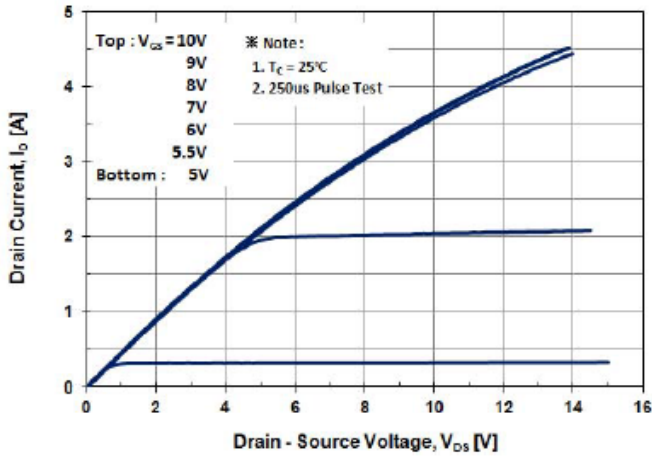


Fig. 2 Typical Output Characteristics

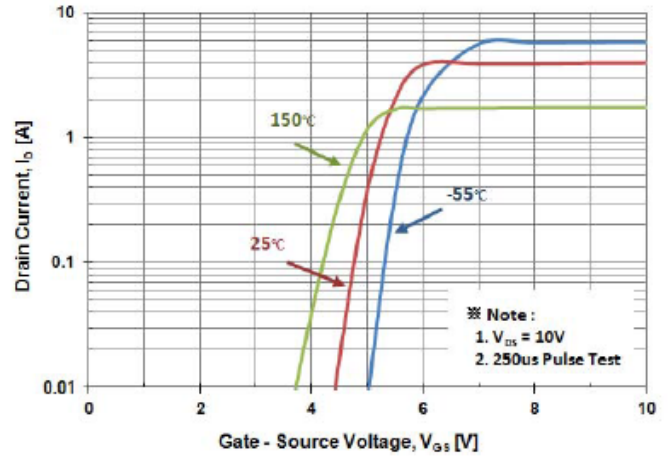


Fig.3 On-Resistance Variation with Drain Current and Gate Voltage

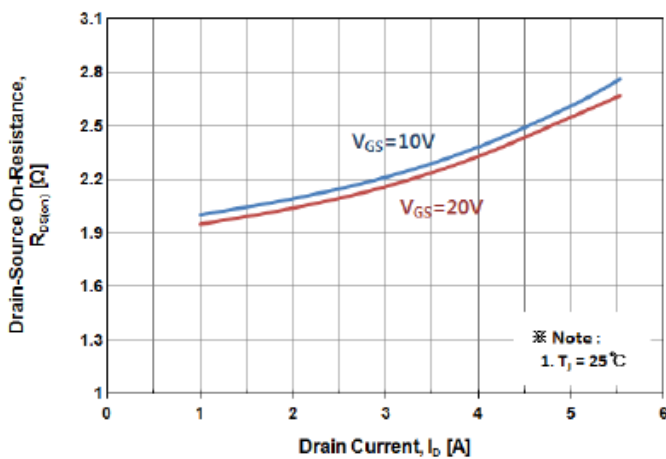


Fig. 4 Body Diode Forward Voltage Variation with Source Current

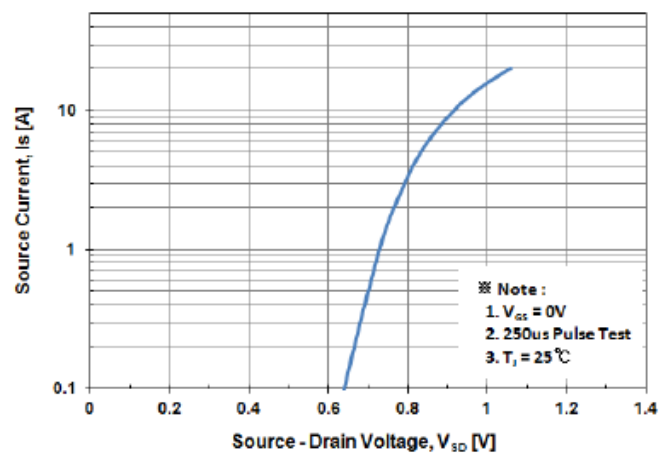


Fig. 5 Typical Capacitance Characteristics

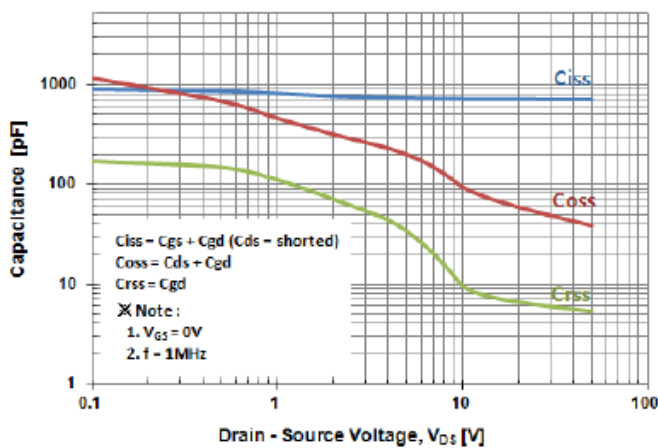
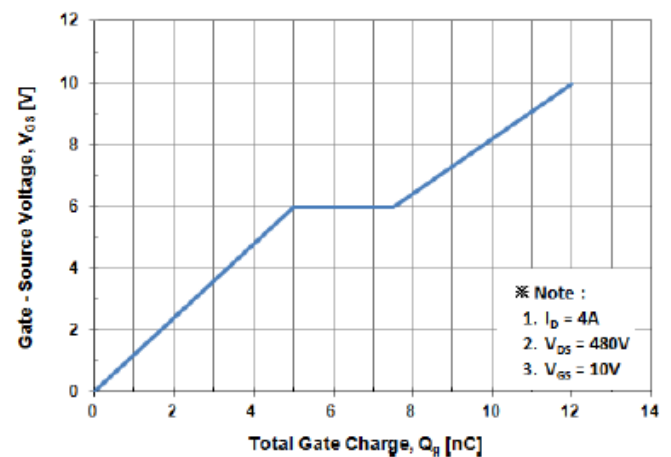


Fig. 6 Typical Total Gate Charge Characteristics



Electrical Characteristic Curves

Fig. 7 Breakdown Voltage Variation vs. Temperature

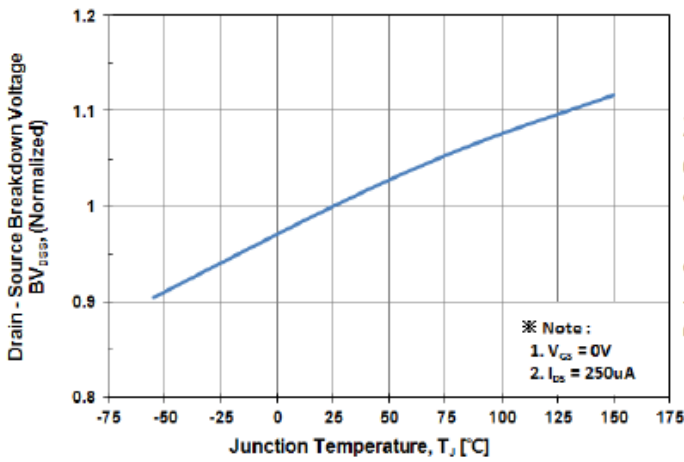


Fig. 8 On-Resistance Variation vs. Temperature

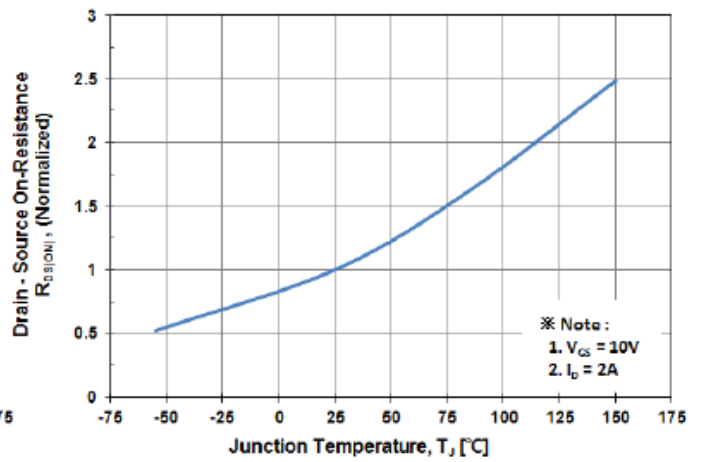


Fig. 9 Maximum Drain Current vs. Case Temperature

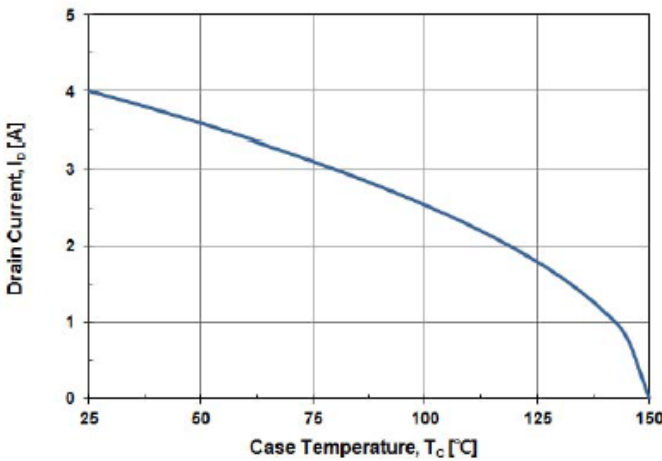


Fig. 10 Maximum Safe Operating Area

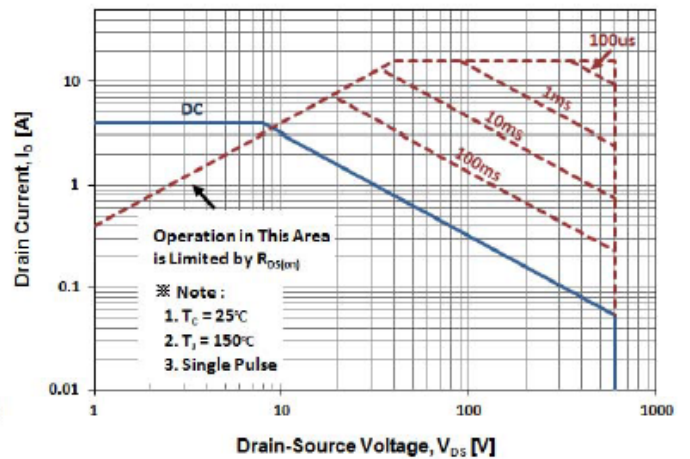
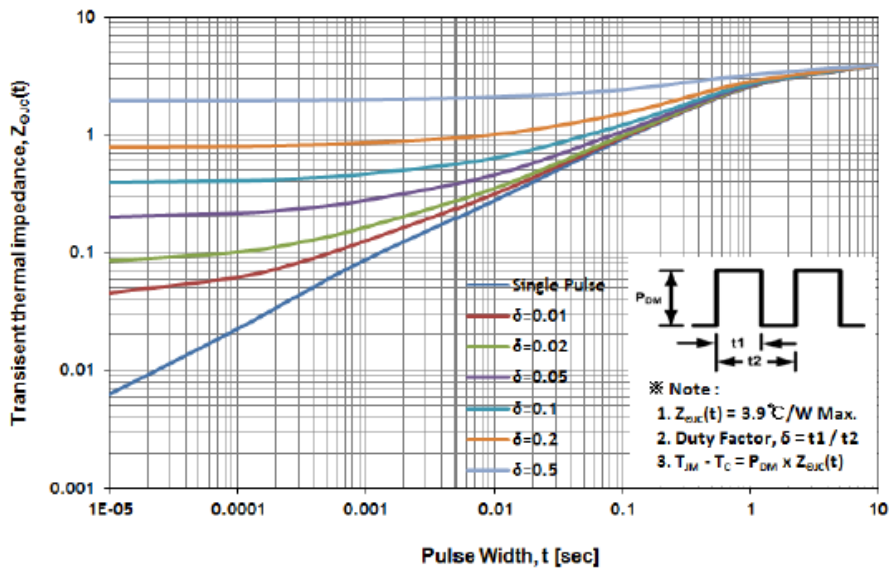
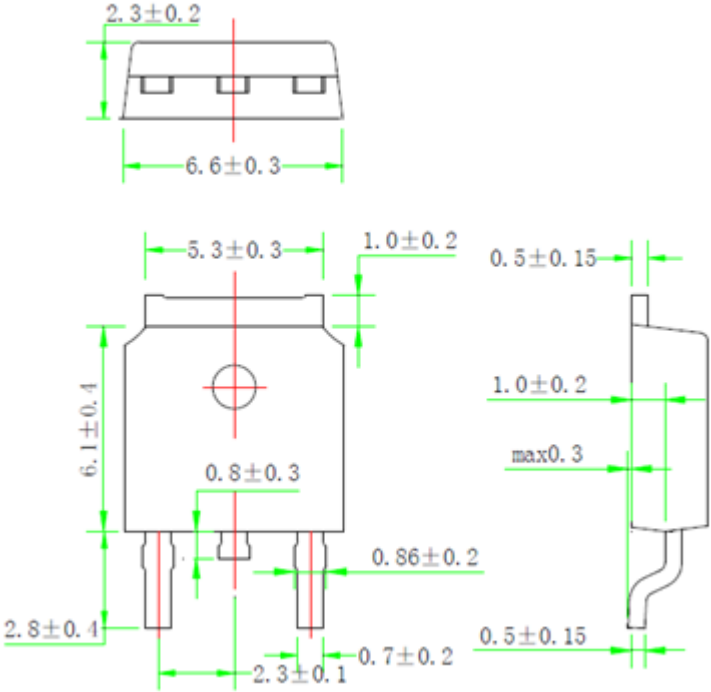


Fig. 11 Transient Thermal Impedance

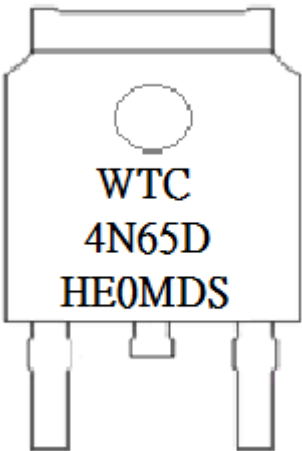


Outline Dimension : TO-252



Unit : mm

Marking Diagram



First Line	WTC	Company Name	
Second Line	4N65D	Product Code	
Third Line	HE0MDS	1st (Year Code)	A-2010 B-2011 C-2012 ...
		2nd (Month Code)	A-Jan B-Feb C-Mar D-Apr E-May F-Jun G-Jul H-Aug I-Sep J-Oct K-Nov L-Dec
		3rd (Lot Code)	0-1 , A-9
		4th (Product Code)	M-MOS , T-Transistor
		5th (Package Code)	I-TO-251 , D-TO-252
		6th (Spec Code)	(Reserve)